



August 2004

## FDJ128N

### N-Channel 2.5 Vgs Specified PowerTrench® MOSFET

#### General Description

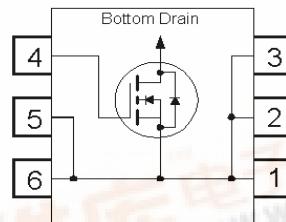
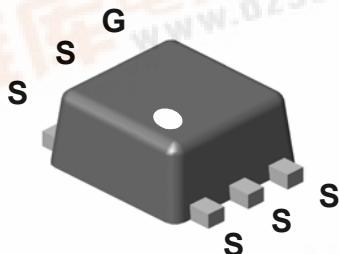
This N-Channel -2.5V specified MOSFET uses Fairchild's advanced low voltage PowerTrench process. It has been optimized for battery power management applications.

#### Applications

- Battery management

#### Features

- 5.5 A, 20 V.  $R_{DS(ON)} = 35 \text{ m}\Omega$  @  $V_{GS} = 4.5 \text{ V}$   
 $R_{DS(ON)} = 51 \text{ m}\Omega$  @  $V_{GS} = 2.5 \text{ V}$
- Low gate charge
- High performance trench technology for extremely low  $R_{DS(ON)}$
- Compact industry standard SC75-6 surface mount package



#### Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain-Source Voltage	20	V
$V_{GSS}$	Gate-Source Voltage	$\pm 12$	V
$I_D$	Drain Current – Continuous (Note 1a)	5.5	A
	– Pulsed	16	
$P_D$	Power Dissipation for Single Operation (Note 1a)	1.6	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	–55 to +150	$^\circ\text{C}$

#### Thermal Characteristics

$R_{QJA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	77	$^\circ\text{C/W}$
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#### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.B	FDJ128N	7"	8mm	3000 units

## Electrical Characteristics

$T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	20			V
$\Delta BV_{DSS}$ $\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$		12		$\text{mV}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}$ , $V_{GS} = 0 \text{ V}$			1	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}$ , $V_{DS} = 0 \text{ V}$			$\pm 100$	$\text{nA}$
<b>On Characteristics</b> (Note 2)						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	0.6	1.0	1.5	V
$\Delta V_{GS(\text{th})}$ $\Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$		-0.3		$\text{mV}/^\circ\text{C}$
$R_{DS(\text{on})}$	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}$ , $I_D = 5.5 \text{ A}$ $V_{GS} = 2.5 \text{ V}$ , $I_D = 4.7 \text{ A}$ $V_{GS} = 4.5 \text{ V}$ , $I_D = 5.5$ , $T_J = 125^\circ\text{C}$	29 41 38	35 51 53		$\text{m}\Omega$
$I_{D(\text{on})}$	On-State Drain Current	$V_{GS} = 4.5 \text{ V}$ , $V_{DS} = 5 \text{ V}$	8			A
$g_{FS}$	Forward Transconductance	$V_{DS} = 5 \text{ V}$ , $I_D = 5.5 \text{ A}$		19		S
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 10 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$		543		pF
$C_{oss}$	Output Capacitance			125		pF
$C_{rss}$	Reverse Transfer Capacitance			65		pF
$R_G$	Gate Resistance	$V_{GS} = 15 \text{ mV}$ , $f = 1.0 \text{ MHz}$		2.0		$\Omega$
<b>Switching Characteristics</b> (Note 2)						
$t_{d(\text{on})}$	Turn-On Delay Time	$V_{DD} = 10 \text{ V}$ , $I_D = 1 \text{ A}$ , $V_{GS} = 4.5 \text{ V}$ , $R_{\text{GEN}} = 6 \Omega$		7	15	ns
$t_r$	Turn-On Rise Time			5	11	ns
$t_{d(\text{off})}$	Turn-Off Delay Time			14	24	ns
$t_f$	Turn-Off Fall Time			3	7	ns
$Q_g$	Total Gate Charge	$V_{DS} = 10 \text{ V}$ , $I_D = 5.5 \text{ A}$ , $V_{GS} = 5 \text{ V}$		5	8	nC
$Q_{gs}$	Gate-Source Charge			1.2		nC
$Q_{gd}$	Gate-Drain Charge			1.4		nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_s$	Maximum Continuous Drain-Source Diode Forward Current			1.3		A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}$ , $I_s = 1.3 \text{ A}$ (Note 2)		0.7	1.2	V
$t_{rr}$	Diode Reverse Recovery Time	$I_F = 5.5 \text{ A}$ , $d_{IF}/d_t = 100 \text{ A}/\mu\text{s}$		12		ns
$Q_{rr}$	Diode Reverse Recovery Charge			3		nC

### Notes:

- $R_{\text{JJA}}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\text{JJC}}$  is guaranteed by design while  $R_{\text{JCA}}$  is determined by the user's board design.



Scale 1 : 1 on letter size paper

a)  $77^\circ\text{C}/\text{W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper.



b)  $115^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width <  $300\mu\text{s}$ , Duty Cycle < 2.0%

## Typical Characteristics

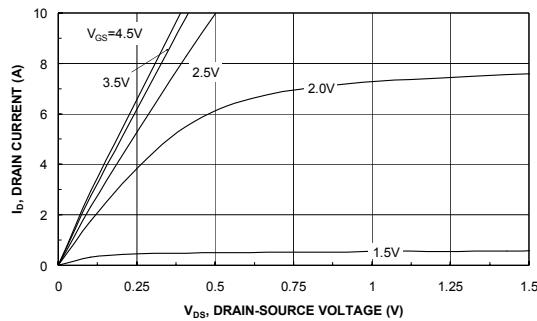


Figure 1. On-Region Characteristics.

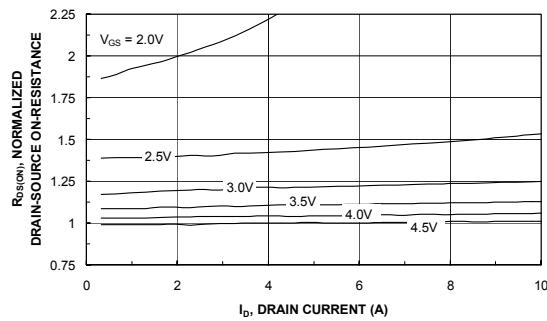


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

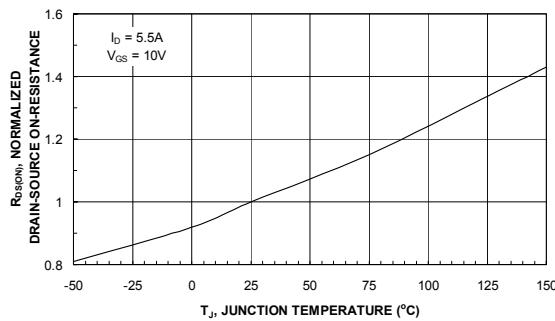


Figure 3. On-Resistance Variation with Temperature.

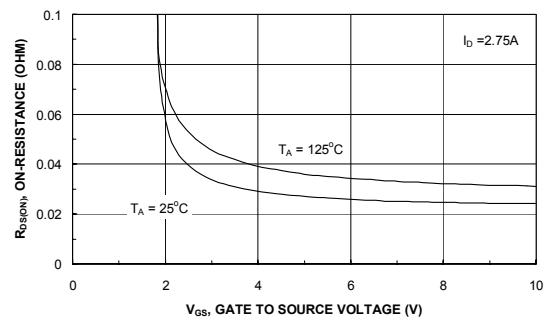


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

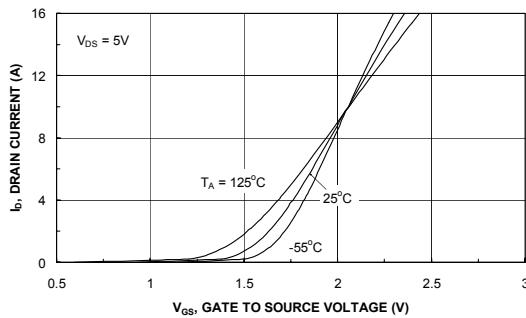


Figure 5. Transfer Characteristics.

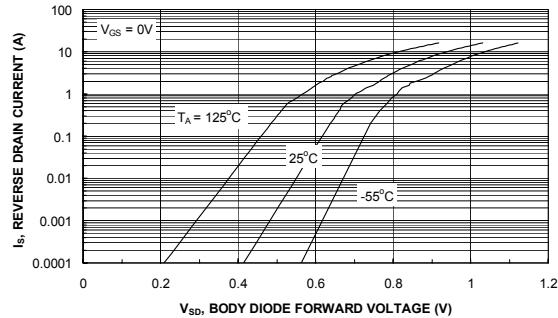


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics

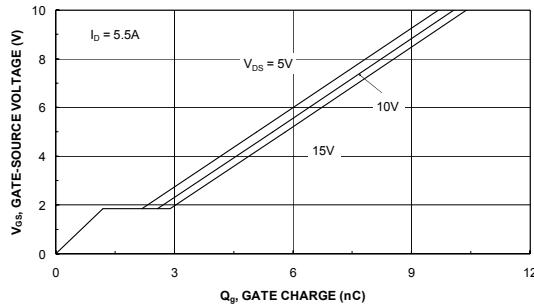


Figure 7. Gate Charge Characteristics.

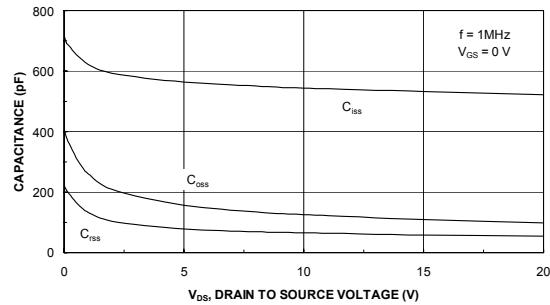


Figure 8. Capacitance Characteristics.

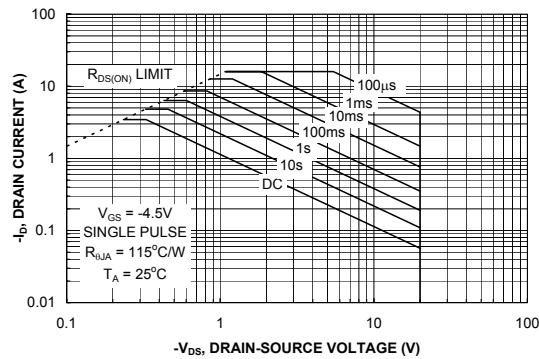


Figure 9. Maximum Safe Operating Area.

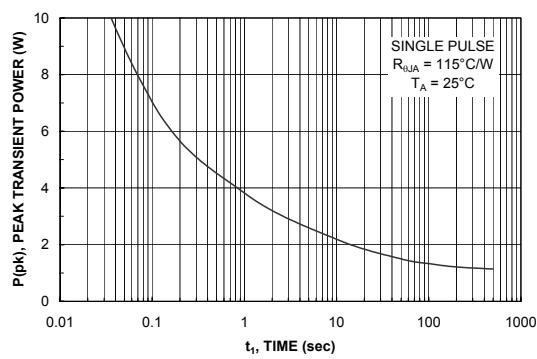


Figure 10. Single Pulse Maximum Power Dissipation.

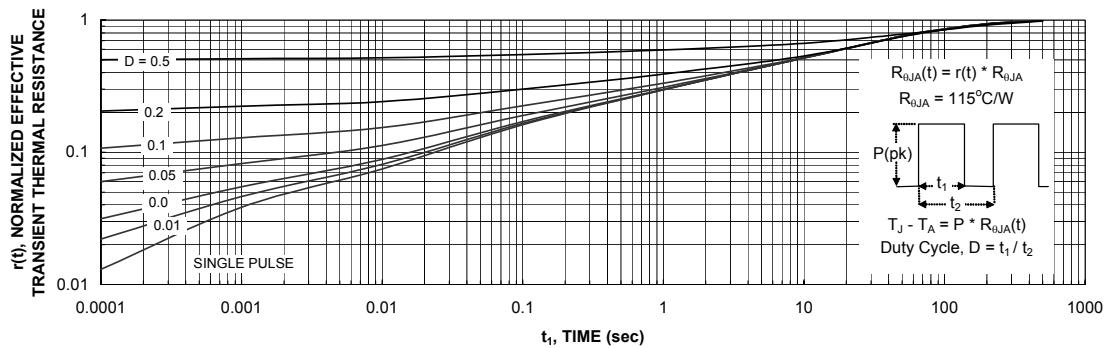
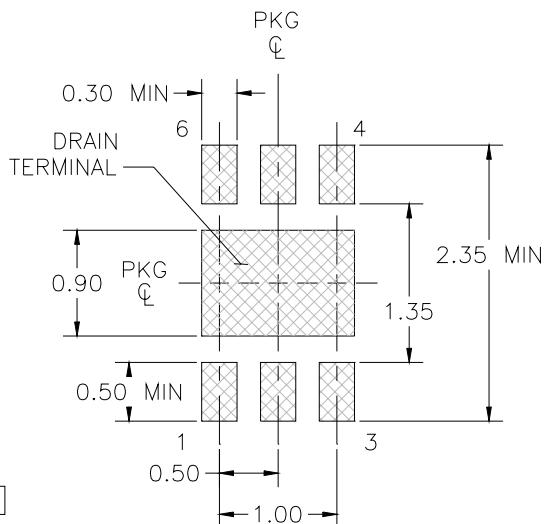
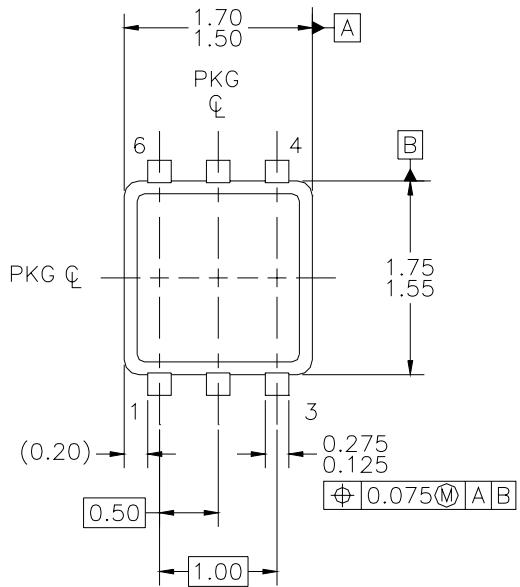


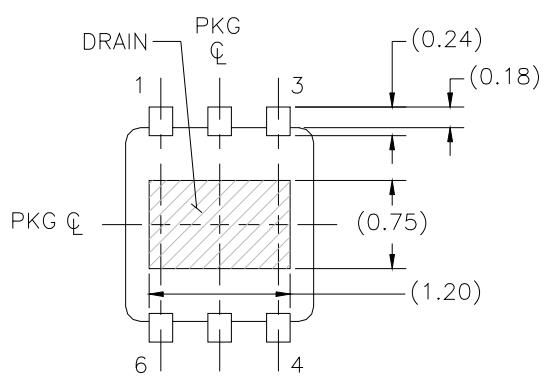
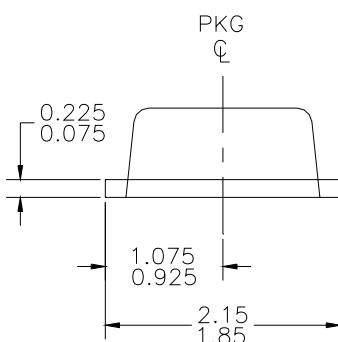
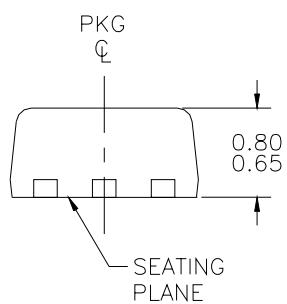
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b.  
Transient thermal response will change depending on the circuit board design.

## Dimensional Outline and Pad Layout



#### LAND PATTERN RECOMMENDATION



### BOTTOM VIEW

NOTES: UNLESS OTHERWISE SPECIFIED

- A) NO PACKAGE STANDARD REFERENCE AS OF JULY 13, 2000.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH.

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